

#### **FEATURES**

- Offers Bandwidth Allocation of PCI Express™ Signal Using Two-Lane 1:2 Multiplexer/Demultiplexer
- Vcc Operating Range From 1.7 V to 1.9 V
- Supports Data Rates of 2.5 Gbps
- Port-Port Crosstalk (–39 dB at 1.25 GHz)
- OFF Port Isolation (–38 dB at 1.25 GHz)
- Low ON-State Resistance (10  $\Omega$  Typ)
- Low Input/Output Capacitance (3.5 pF Typ)

- Excellent Differential Skew (5 ps Max)
- Minimal Propagation Delay
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

#### **DESCRIPTION/ORDERING INFORMATION**

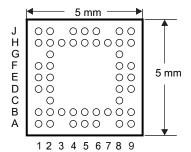
The TS2PCIE2212 can be used to muxltiplex/demultiplex two PCI Express™ lanes, each representing differential pairs of receive (RX) and transmit (TX) signals. The switch operates at the PCI Express bandwidth standard of 2.5-Gbps signal-processing speed. The device is composed of two banks, with each bank accommodating two sources (source A and source B) and two destinations (destination A and destination B).

When a logic-level low is applied to the control (CTRL) pin, source A is connected to destination A and source B is connected to destination B. When a logic-level high is applied to CTRL, source A is connected to destination B, while source B and destination A are open.

#### ORDERING INFORMATION

T <sub>A</sub>	PACKAGE		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 85°C	BGA – ZAH	Tape and reel	TS2PCIE2212ZAHR	

# ZAH PACKAGE (BOTTOM VIEW)



#### **TERMINAL ASSIGNMENTS**

	1	2	3	4	5	6	7	8	9
Α	CTRL0	TxSB:0P		TxSA:0P	GND	TxDA:0P		TxDB:0P	NC
В	RxSA:0P	GND	TxSB:0N	TxSA:0N	VDD	TxDA:0N	TxDB:0N	GND	RxDA:0P
С		RxSA:0N						RxDA:0N	
D	RxSB:0P	RxSB:0N					RxDB:0N	RxDB:0P	
E	GND	VDD						VDD	GND
F	TxSA:1P	TxSA:1N						TxDA:1N	TxDA:1P
G		TxSB:1N						TxDB:1N	
Н	TxSB:1P	GND	RxSA:1N	RxSB:1N	VDD	RxDB:1N	RxDA:1N	GND	TxDB:1P
J	NC	RxSA:1P		RXSB:1P	GND	RXDB:1P		RxDA:1P	CTRL1

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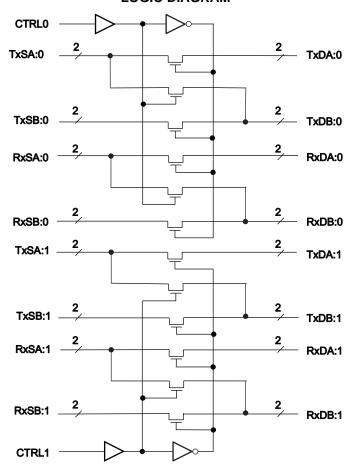
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### **PIN DESCRIPTION**

NAME	FUNCTION
TxSA:nP, TxSA:nN	Source A transmit pair
RxSA:nP, RxSA:nN	Source A receive pair
TxSB:nP, TxSB:nN	Source B transmit pair
RxSB:nP, RxSB:nN	Source B receive pair
TxDA:nP, TxDA:nN	Destination A transmit pair
RxDA:nP, RxDA:nN	Destination A receive pair
TxDB:nP, TxDB:nN	Destination B transmit pair
RxDB:nP, RxDB:nN	Destination B receive pair
CTRL0	Control signal for bank 0
CTRL1	Control signal for bank 1
$V_{DD}$	Positive supply voltage
GND	Ground (0 V)
NC	No internal connection

### **LOGIC DIAGRAM**





SCDS209-JUNE 2006

#### **FUNCTION TABLE**

CTRLn	FUNCTION
L	SA:n = DA:n, SB:n = DB:n
Н	SA:n = DB:n, DA:n = open, SBin = open

# Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{DD}$	Supply voltage range		-0.5	2.5	V
V <sub>IN</sub>	Control input voltage range <sup>(2)(3)</sup>		-0.5	2.5	V
V <sub>I/O</sub>	Switch I/O voltage range <sup>(2)(3)(4)</sup>		-0.5	2.5	V
I <sub>IK</sub>	Control input clamp current	$V_{IN} < 0$ and $V_{I/O} < 0$		50	mA
I <sub>I/OK</sub>	I/O port clamp current	V <sub>IN</sub> < 0 and V <sub>I/O</sub> < 0		50	mA
I <sub>I/O</sub>	ON-state switch current <sup>(5)</sup>			±100	mA
	Continuous current through V <sub>DD</sub> or GND			±100	mA
$\theta_{JA}$	Package thermal impedance (6)			TBD	°C/W
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to ground, unless otherwise specified.

### **Recommended Operating Conditions**

			MIN	TYP	MAX	UNIT
$V_{DD}$	Supply voltage		1.7	1.8	1.9	V
$V_{IH}$	High-level control input voltage	CTRL	0.65 V <sub>DD</sub>			V
V <sub>IL</sub>	Low-level control input voltage	CTRL			0.35 V <sub>DD</sub>	V
V <sub>IO</sub>	Data input/output voltage		0		$V_{DD}$	V
T <sub>A</sub>	Operating free-air temperature		0		85	°C

The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup>  $V_1$  and  $V_0$  are used to denote specific conditions for  $V_{1/0}$ .

 <sup>(5)</sup> I<sub>I</sub> and I<sub>O</sub> are used to denote specific conditions for I<sub>I/O</sub>.
(6) The package thermal impedance is calculated in accordance with JESD 51-7.



# **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS			$T_A = 0^{\circ}C$ to $85^{\circ}C$		
		TEST CONDITIONS				TYP	MAX	UNIT
V <sub>IK</sub>	Control inputs	V <sub>DD</sub> = 1.7 V,	$I_{IN} = -18 \text{ mA}$				-1.8	V
I <sub>IN</sub>	Control inputs	V <sub>DD</sub> = 1.9 V,	$V_{IN} = V_{DD}$ or GND				±1	μΑ
I <sub>OZ</sub>		V <sub>DD</sub> = 1.9 V,	$V_O = 0 \text{ to } 1.9 \text{ V},$ $V_I = 0,$	Switch OFF			±5	μΑ
I <sub>CC</sub>		$V_{DD} = 1.9 \text{ V},$ $V_{IN} = V_{DD} \text{ or GND},$	$I_{I/O} = 0,$	Switch ON or OFF		160	300	μΑ
C <sub>in</sub>	Control inputs	V <sub>DD</sub> = 1.9 V,	$V_{IN} = V_{DD}$ or GND			0.5	1.0	pF
C <sub>IO(OFF)</sub>	SB or DA port	$V_{I/O} = 0 V$ ,	Switch OFF			1.4	1.5	pF
C <sub>IO(ON)</sub>		$V_{I/O} = 0 V$ ,	Switch ON			3.5	4	pF
_		V <sub>DD</sub> = 1.7 V,	V <sub>I</sub> = 0 V,	I <sub>O</sub> = 10 mA		10	14	Ω
r <sub>on</sub>		V <sub>DD</sub> = 1.7 V,	V <sub>I</sub> = 1.5 V,	I <sub>O</sub> = -10 mA		12	17	2.2
$\Delta r_{on(flat)}$		V <sub>DD</sub> = 1.7 V,	I <sub>O</sub> = 10 mA,	$V_{I} = 1.5 \text{ V} \pm 0.4 \text{ V}$		2.5	5	Ω

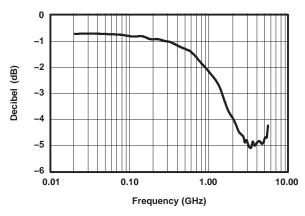
# **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	TEST CONDITIONS	T <sub>A</sub> =	UNIT		
PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN	TYP	MAX	UNII
DR	Data rate per TX or RX pair			2.5		Gbps
t <sub>pd</sub>	Propagation delay, Sx to Dx	See Figure 7		250		ps
t <sub>sk</sub>	Intra-pair skew	f =1.25 GHz, See Figure 7			5	ps
t <sub>en</sub> (t <sub>PZL</sub> , t <sub>PZH</sub> )	Switch turn-on delay, CTRL to DA	See Figure 6			5	ns
t <sub>dis</sub> (t <sub>PLZ</sub> , t <sub>PHZ</sub> )	Switch turn-off delay, CTRL to DA	See Figure 6			2.5	ns
I <sub>LOSS</sub>	Differential insertion loss	f =1.25 GHz, $R_{LOAD}$ = 50 $\Omega$ , See Figure 1		-2.5	-3.2	dB
R <sub>LOSS</sub>	Differential return loss	f =1.25 GHz, $R_{LOAD}$ = 50 $\Omega$ , See Figure 2	-7.2	-9.5		dB
I <sub>LOSS(CM)</sub>	Common-mode insertion loss	f =1.25 GHz, $R_{LOAD}$ = 50 $\Omega$ , See Figure 3		-2		dB
O <sub>IFF</sub>	Differential OFF isolation	f =1.25 GHz, $R_{LOAD}$ = 50 $\Omega$ , See Figure 4	-33	-38		dB
X <sub>TALK</sub>	Differential crosstalk	f =1.25 GHz, $R_{LOAD}$ = 50 $\Omega$ , See Figure 5	-33	-39		dB



### **OPERATING CHARACTERISTICS**



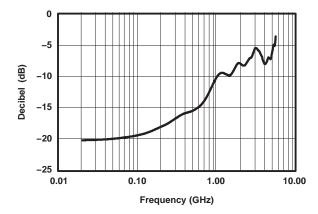


Figure 1. Differential Insertion Loss vs Frequency

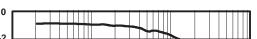
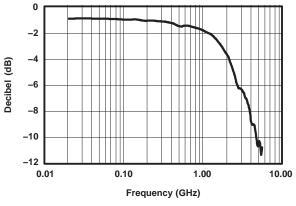


Figure 2. Differential Return Loss vs Frequency



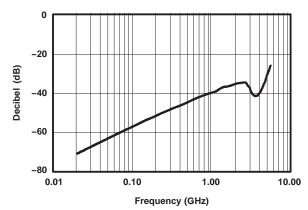


Figure 3. Common-Mode Insertion Loss vs Frequency

Figure 4. Differential OFF Isolation vs Frequency

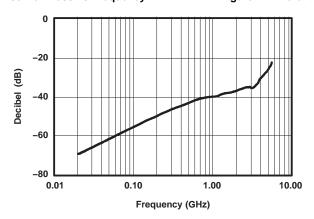
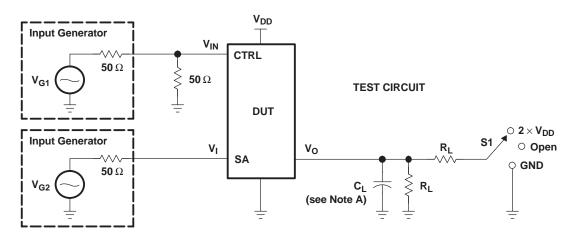


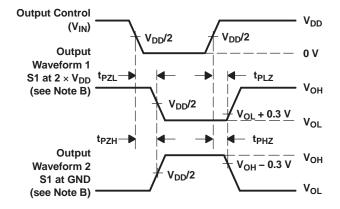
Figure 5. Differential Crosstalk vs Frequency



# PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



TEST	V <sub>CC</sub>	S1	$R_{L}$	VI	CL	${f V}_{\Delta}$
$t_{PLZ}/t_{PZL}$	1.8 V ± 0.1 V	$2 \times V_{DD}$	100 Ω	GND	No Load	0.3 V
t <sub>PHZ</sub> /t <sub>PZH</sub>	1.8 V ± 0.1 V	GND	100 Ω	$V_{DD}$	No Load	0.3 V



VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES

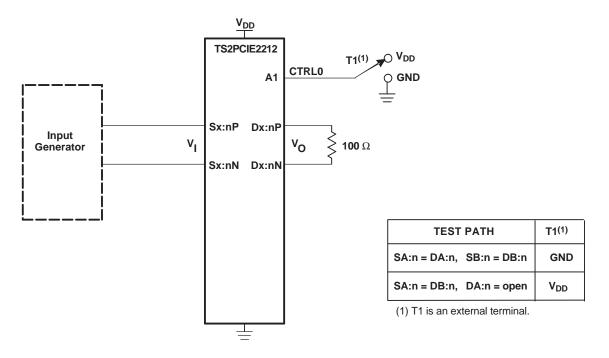
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

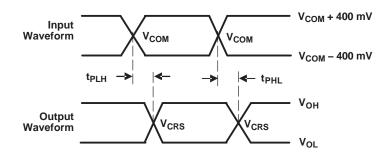
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f \leq$  2.5 ns.  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.

Figure 6. Test Circuit and Voltage Waveforms



### PARAMETER MEASUREMENT INFORMATION





 $V_{COM} = 1.5 V$ 

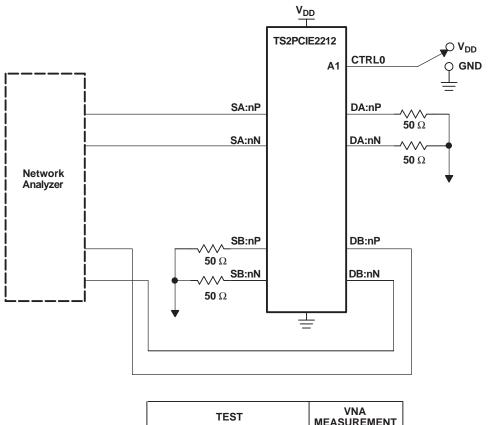
 $\ensuremath{\text{V}_{\text{CRS}}}\xspace$  is the cross point of the differential signal.

 $t_{sk} = |t_{PLHn} - t_{PHLn}|$ 

Figure 7. Test Circuit for Propagation Delay and Intra-Pair Skew



# PARAMETER MEASUREMENT INFORMATION (continued)

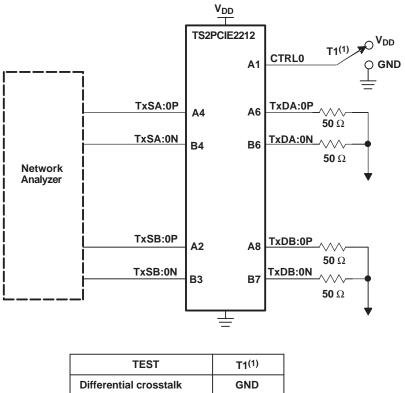


TEST	VNA MEASUREMENT
Differential insertion loss	S <sub>21</sub>
Differential return loss	S <sub>11</sub>
Common-mode insertion loss	S <sub>21</sub>

Figure 8. Differential Insertion Loss, Differential Return Loss, and Common-Mode Insertion Loss Test Circuit



# PARAMETER MEASUREMENT INFORMATION (continued)



TEST	T1 <sup>(1)</sup>
Differential crosstalk	GND
Differential OFF isolation	V <sub>DD</sub>

(1) T1 is an external terminal.

Figure 9. Differential Crosstalk and OFF Isolation Test Circuit



#### PACKAGE OPTION ADDENDUM

18-Jul-2006

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TS2PCIE2212ZAHR	ACTIVE	BGA	ZAH	48	3000	Pb-Free (RoHS)	SNAGCU	Level-3-260C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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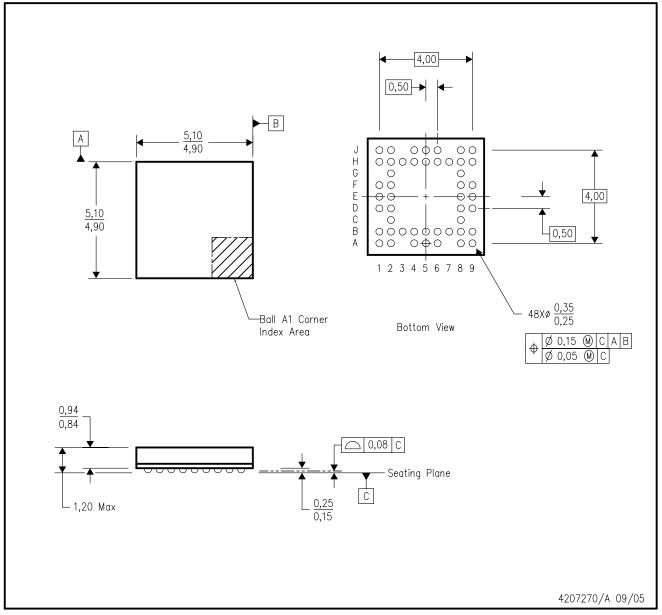
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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# ZAH (S-PBGA-N48)

# PLASTIC BALL GRID ARRAY



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. JEDEC MO-225 registration is pending.
- D. This is a lead-free solder ball design.



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